## Notice of References Cited

Application/Control No. 09/766,473	Applicant(s)/Pater Reexamination KIM ET AL.	nt Under
Examiner	Art Unit	
BENJAMIN AILES	2442	Page 1 of 1

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2001/0037380 A1	11-2001	Wall et al.	709/219
*	В	US-5,758,355	05-1998	Buchanan, David D.	707/201
*	С	US-2002/0065926 A1	05-2002	Hackney et al.	709/231
*	D	US-5,999,947	12-1999	Zollinger et al.	707/203
*	Е	US-2006/0265471 A1	11-2006	Pitzel et al.	709/217
*	F	US-6,522,738 B1	02-2003	Cruickshank et al.	379/201.03
*	G	US-7,058,704 B1	06-2006	Mangipudi et al.	709/223
	Н	US-			
	- 1	US-			
	J	US-			
	к	US-			
	L	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

	FOREIGN FATENT DOCUMENTS					
*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
	R					
	s					
	т					

## NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	v	
	w	
	х	

A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.